

Notice of References Cited	Application/Control No. 10/805,008		Applicant(s)/Patent Under Reexamination KAUFMAN ET AL.	
	Examiner Vivian Chen		Art Unit 1773	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,955,529	09-1999	Imai et al.	524/417
*	B	US-2003/0166748	09-2003	Khemani et al.	524/47
*	C	US-6,787,245	09-2004	Hayes, Richard Allen	428/480
*	D	US-2005/0208294	09-2005	Kaufman et al.	428/330
*	E	US-2002/0128344	09-2002	Fujihira et al.	522/162
*	F	US-2003/0088033	05-2003	Shelby et al.	525/444
*	G	US-6,703,115	03-2004	Hale et al.	428/212
*	H	US-6,342,304	01-2002	Buchanan et al.	428/480
*	I	US-5,292,783	03-1994	Buchanan et al.	524/37
*	J	US-2003/0204027	10-2003	Autran, Jean-Philippe Marie	525/418
*	K	US-2003/0191210	10-2003	Autran, Jean-Philippe Marie	523/105
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.